

BCW 31, BCW 32, BCW 33

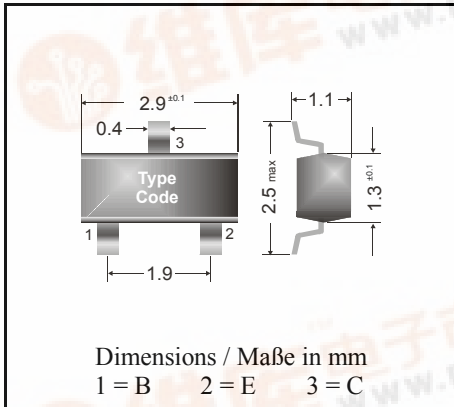


General Purpose Transistors

NPN

Surface mount Si-Epitaxial Planar Transistors
Si-Epitaxial Planar Transistoren für die Oberflächenmontage

NPN



Power dissipation – Verlustleistung 250 mW

Plastic case SOT-23
 Kunststoffgehäuse (TO-236)

Weight approx. – Gewicht ca. 0.01 g

Plastic material has UL classification 94V-0
 Gehäusematerial UL94V-0 klassifiziert

Standard packaging taped and reeled
 Standard Lieferform gegurtet auf Rolle

Maximum ratings (T_A = 25°C)

Grenzwerte (T_A = 25°C)

			BCW 31, BCW 32, BCW 33
Collector-Emitter-voltage	B open	V _{CE0}	32 V
Collector-Base-voltage	E open	V _{CB0}	32 V
Emitter-Base-voltage	C open	V _{EB0}	5 V
Power dissipation – Verlustleistung		P _{tot}	250 mW ¹⁾
Collector current – Kollektorstrom (DC)		I _C	100 mA
Peak Collector current – Kollektor-Spitzenstrom		I _{CM}	200 mA
Peak Base current – Basis-Spitzenstrom		I _{BM}	200 mA
Junction temperature – Sperrschichttemperatur		T _j	150°C
Storage temperature – Lagerungstemperatur		T _s	- 65...+ 150°C

Characteristics (T_j = 25°C)

Kennwerte (T_j = 25°C)

	Min.	Typ.	Max.
Collector-Base cutoff current – Kollektorreststrom			
I _E = 0, V _{CB} = 32 V	I _{CB0}	–	100 nA
I _E = 0, V _{CB} = 32 V, T _j = 100°C	I _{CB0}	–	10 µA
Emitter-Base cutoff current – Emittorreststrom			
I _C = 0, V _{EB} = 5 V	I _{EB0}	–	100 nA
Collector saturation volt. – Kollektor-Sättigungssp. ²⁾			
I _C = 10 mA, I _B = 0.5 mA	V _{CEsat}	–	120 mV
I _C = 50 mA, I _B = 5 mA	V _{CEsat}	–	210 mV



¹⁾ Mounted on P.C. board with 3 mm² copper pad at each terminal

Montage auf Leiterplatte mit 3 mm² Kupferbelag (Löt-pad) an jedem Anschluß

²⁾ Tested with pulses t = 300 µs, duty cycle < 2% – Gemessen mit Impulsen t = 300 µs, Schaltverhältnis < 2%

Characteristics ($T_j = 25^\circ\text{C}$)

Kennwerte ($T_j = 25^\circ\text{C}$)

		Min.	Typ.	Max.	
Base saturation voltage – Basis-Sättigungsspannung ¹⁾					
$I_C = 10\text{ mA}, I_B = 0.5\text{ mA}$	V_{BEsat}	–	750 mV	–	
$I_C = 50\text{ mA}, I_B = 2.5\text{ mA}$	V_{BEsat}	–	850 mV	–	
DC current gain – Kollektor-Basis-Stromverhältnis ¹⁾					
$V_{CE} = 5\text{ V}, I_C = 10\ \mu\text{A}$	BCW 31	h_{FE}	–	190	–
	BCW 32	h_{FE}	–	330	–
	BCW 33	h_{FE}	–	600	–
$V_{CE} = 5\text{ V}, I_C = 2\text{ mA}$	BCW 31	h_{FE}	110	–	220
	BCW 32	h_{FE}	200	–	450
	BCW 33	h_{FE}	420	–	800
Base-Emitter voltage – Basis-Emitter-Spannung ¹⁾					
$V_{CE} = 5\text{ V}, I_C = 2\text{ mA}$	V_{BEon}	550 mV	–	700 mV	
Gain-Bandwidth Product – Transitfrequenz					
$V_{CE} = 5\text{ V}, I_C = 10\text{ mA}, f = 100\text{ MHz}$	f_T	100 MHz	–	–	
Collector-Base Capacitance – Kollektor-Basis-Kapazität					
$V_{CB} = 10\text{ V}, I_E = i_e = 0, f = 1\text{ MHz}$	C_{CB0}	–	2.5 pF	–	
Noise figure – Rauschzahl					
$V_{CE} = 5\text{ V}, I_C = 200\ \mu\text{A}, R_G = 2\text{ k}\Omega,$ $f = 1\text{ kHz}, \Delta f = 200\text{ Hz}$	F	–	–	10 dB	
Thermal resistance junction to ambient air Wärmewiderstand Sperrschicht – umgebende Luft		R_{thA}		420 K/W ²⁾	
Recommended complementary PNP transistors Empfohlene komplementäre PNP-Transistoren			BCW 29, BCW 30		
Marking – Stempelung	BCW 31 = D1	BCW 32 = D2	BCW 33 = D3		

¹⁾ Tested with pulses $t_p = 300\ \mu\text{s}$, duty cycle $\leq 2\%$ – Gemessen mit Impulsen $t_p = 300\ \mu\text{s}$, Schaltverhältnis $\leq 2\%$

²⁾ Mounted on P.C. board with 3 mm² copper pad at each terminal
Montage auf Leiterplatte mit 3 mm² Kupferbelag (Lötpad) an jedem Anschluß